



FORM PTO-1449 (MODIFIED)

LIST OF PATENTS AND PUBLICATIONS  
FOR APPLICANTS INFORMATION  
DISCLOSURE STATEMENT

ATTORNEY DOCKET NO.

SP02-199

SERIAL NO.

10/659525

APPLICANT: Hrdina, et al.

FILING DATE 9/9/2003

GROUP: TBD

- REFERENCE DESIGNATION

U.S. PATENT DOCUMENTS

Examiner Initial		Document Number	Date	Name	Class	Sub-Class	Filing Date if Approp.
QSD	AA	2002/0026810	3/7/02	Clasen et al	65	17.6	
	AB	2002/0043080	4/18/02	Best et al	65	61	
	AC	2003/0159464	8/28/03	Bowden et al	65	17.2	
	AD	2003/0159465	8/28/03	Bowden et al	65	17.3	
	AE	2003/0159466	8/28/03	Bowden et al	65	17.6	
	AF	2003/0226377	12/11/03	Barrett et al	65	17.4	
	AG	3,790,654	2/5/74	Bagley			
	AH	4,612,023	9/16/86	Kreutzer et al	65	32	
	AI	4,789,389	12/6/88	Schermerhorn et al	65	3.12	
	AJ	4,902,216	2/20/90	Cunningham et al	425	463	
	AK	4,940,675	7/10/90	Bohlayer et al	501	12	
	AL	5,154,744	10/13/92	Blackwell et al	65	3.12	
	AM	5,443,607	8/22/95	Englisch et al	65	64	
	AN	6,209,357	4/3/01	Bhandarkar et al	65	395	
QSD	AO	6,415,630	7/9/02	Coriand et al	65	57	
	AP	6,553,789	4/29/03	Martin et al	65	67	

FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Sub-Class	Translation Yes	No
QSD	AQ	WO02/088035	11/7/02	PCT	C03B	8/04	X	
	AR	WO02/088036	3/25/02	PCT	C03B	8/04	X	
	AS	WO02/26647	4/4/02	PCT	C03B	37/016	X	
	AT	WO02/32616	4/25/02	PCT	B23P	13/04	X	
	AU	WO02/32622	4/28/02	PCT	B24B	7/24	X	
	AV	WO03/057633	7/17/03	PCT	C03B	20/00	X	
	AW	WO03/077038	9/18/03	PCT	G03B	7/20	X	
QSD	AX	EP1106582	6/13/01	Europe	C03B	19/10	X	

OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)

QSD	AY	Charles A. Harper, Handbook of Ceramics, Glasses and Diamonds, Chapter 6.2.9, Paragraph 6.2.9.3.
	AZ	Hrdina et al. "Measureing and Tailoring CTE within ULE® Glass", in Glass, in <u>Microlithography 2003</u> , Proceedings of SPIE, Volume 5037
	BA	Stulen et al. "Extreme Ultraviolet Lithography", IEE Journal of Quantum Electronics, Vol. 35, No. 5, May 1999, Pages 694-699.
	BB	Mazurin et al. "Crystallization of Silica and Titanium Oxide-Silica Corning Glasses (Codes 7940 and 7971)", Journal of Non-Crystalline Solids 18 (1975), pages 1-9
QSD	BC	Presentation entitled "EUV Lithography NGL Technology Review", given at NGL Workshop, Chicago, Illinois, June 9, 1990

EXAMINER:

/Queenie Dehghan/

DATE CONSIDERED:

09/06/2006

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609: draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.